



# PJM6016NPA

## Single N-Channel Power MOSFET

### Features

The PJM6016NPA uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge.

- Fast Switching
- Low Gate Charge and  $R_{DS(on)}$
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test

•  $V_{DSS}=60V$

$I_D=16A$

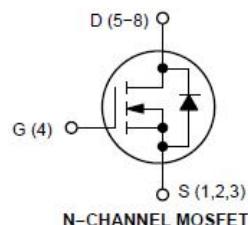
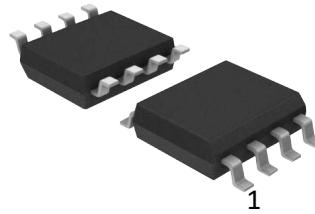
$PD=3W$

$R_{DS(ON)} < 9m\Omega @ V_{GS}=10V$  (Typ 7.5m $\Omega$ )

### Applications

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply

SOP-8



### Absolute Maximum Ratings ( $T_c=25^\circ C$ unless otherwise specified)

Symbol	Parameter	Rating	Units
$V_{DSS}$	Drain-to-Source Voltage	60	V
$I_D$	Continuous Drain Current	16	A
	Continuous Drain Current $T_c = 100^\circ C$	12	A
$I_{DM}$	Pulsed Drain Current	54	A
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}^{a2}$	Single Pulse Avalanche Energy	90	mJ
$E_{AR}^{a1}$	Avalanche Energy ,Repetitive	20	mJ
$I_{AR}^{a1}$	Avalanche Current	10	A
$dv/dt$ <sup>a3</sup>	Peak Diode Recovery $dv/dt$	5.0	V/ns
$P_D$	Power Dissipation	3.0	W
$T_J, T_{stg}$	Operating Junction and Storage	175, -55 to 175	°C
$T_L$	Maximum Temperature for Soldering	300	°C

### Thermal Characteristics

Symbol	Parameter	Typ	Units
$R_{\theta JA}$	Thermal Resistance,Junction-to-Case	42	°C / W



**Electrical Characteristics (T<sub>C</sub>=25°C unless otherwise specified)**

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
<b>Off Characteristics</b>						
V <sub>DSS</sub>	Drain to Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	60	--	--	V
I <sub>DSS</sub>	Drain to Source Leakage Current	V <sub>DS</sub> =60V, V <sub>GS</sub> =0V, T <sub>a</sub> =25°C	--	--	1.0	μA
		V <sub>DS</sub> =48V, V <sub>GS</sub> =0V, T <sub>a</sub> =125°C			250	
I <sub>GSS(F)</sub>	Gate to Source Forward Leakage	V <sub>GS</sub> =+20V	--	--	1	μA
I <sub>GSS(R)</sub>	Gate to Source Reverse Leakage	V <sub>GS</sub> =-20V	--	--	-1	μA
<b>On Characteristics</b>						
R <sub>DS(ON)</sub>	Drain-to-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =16A	--	7.5	9.0	mΩ
V <sub>GS(TH)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	1.0	1.3	2.0	V
Pulse width<380μs; duty cycle<2%.						
<b>Dynamic Characteristics</b>						
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =16A	40	--	--	S
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =30V, f=1.0MHz	--	4100	--	pF
C <sub>oss</sub>	Output Capacitance		--	300	--	
C <sub>rss</sub>	Reverse Transfer Capacitance		--	230	--	
<b>Resistive Switching Characteristics</b>						
t <sub>d(ON)</sub>	Turn-on Delay Time	I <sub>D</sub> =16A, V <sub>DD</sub> =30V V <sub>GS</sub> =10V, R <sub>g</sub> =3.0Ω	--	10		ns
t <sub>r</sub>	Rise Time		--	9		
t <sub>d(OFF)</sub>	Turn-Off Delay Time		--	45		
t <sub>f</sub>	Fall Time		--	18		
Q <sub>g</sub>	Total Gate Charge	I <sub>D</sub> =16A, V <sub>DD</sub> =30V, V <sub>GS</sub> =10V	--	100		nC
Q <sub>gs</sub>	Gate to Source Charge		--	10	--	
Q <sub>gd</sub>	Gate to Drain ("Miller") Charge		--	22	--	
<b>Source-Drain Diode Characteristics</b>						
I <sub>SD</sub>	Continuous Source Current (Body Diode)		--	--	14	A
V <sub>SD</sub>	Diode Forward Voltage	I <sub>s</sub> =16A, V <sub>GS</sub> =0V	--	--	1.2	V
I <sub>s</sub>	Continuous Source Current (Body Diode)		--	--	16	A
I <sub>SM</sub>	Maximum Pulsed Current (Body Diode)		--	--	54	A
V <sub>SD</sub>	Diode Forward Voltage	I <sub>s</sub> =16A, V <sub>GS</sub> =0V	--	--	1.5	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>s</sub> =16A, T <sub>j</sub> =25°C dI <sub>F</sub> /dt=100A/us, V <sub>GS</sub> =0V	--	35	--	ns
Q <sub>rr</sub>	Reverse Recovery Charge		--	48	--	nC
Pulse width<380μs; duty cycle<2%.						

a1: Repetitive Rating: Pulse width limited by maximum junction temperature.

a2: EAS condition: T<sub>J</sub>=25°C, V<sub>DD</sub>=30V, V<sub>G</sub>=10V, L=0.5mH, R<sub>g</sub>=25Ω

a3: I<sub>SD</sub>=16A, di/dt ≤ 100A/us, V<sub>DD</sub>≤BV<sub>DS</sub>, Start T<sub>j</sub>=25°C



### Test Circuit and Waveform

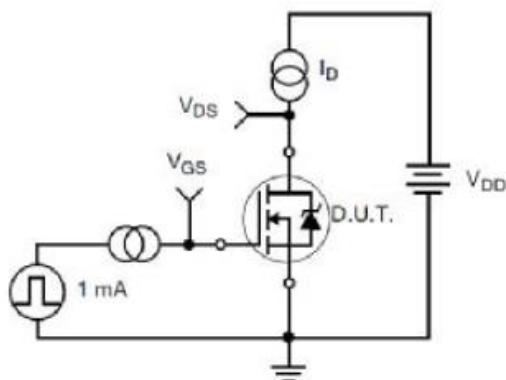


Figure 17. Gate Charge Test Circuit.

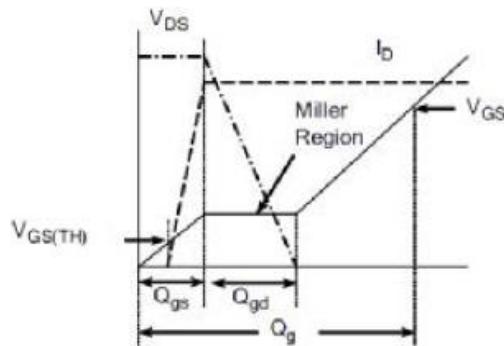


Figure 18. Gate Charge Waveform

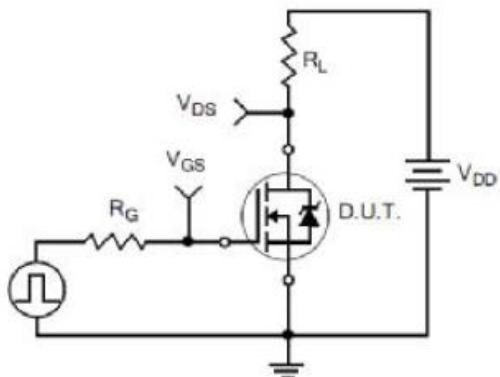


Figure 19. Resistive Switching Test Circuit.

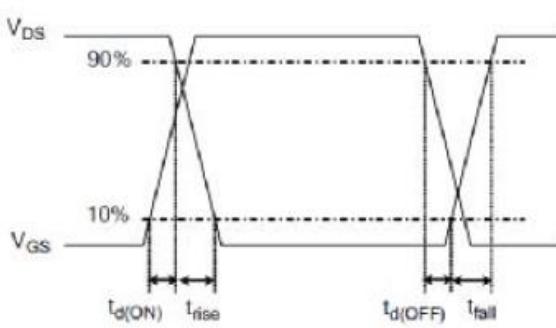


Figure 20. Resistive Switching Waveforms



## Typical Characteristic Curves

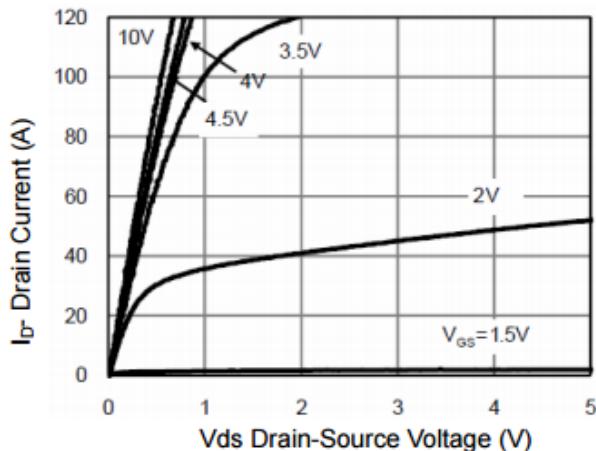


Figure 1 Output Characteristics

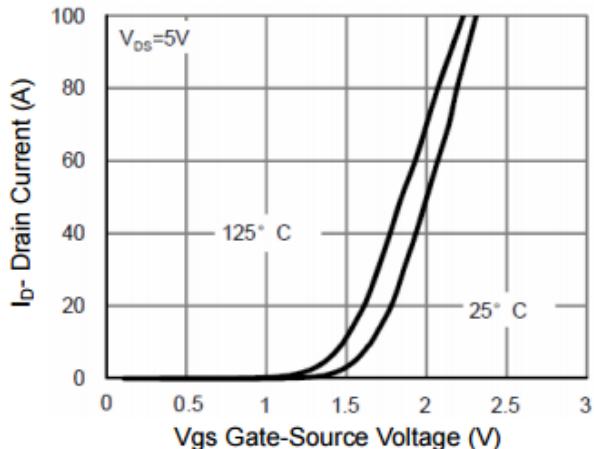


Figure 2 Transfer Characteristics

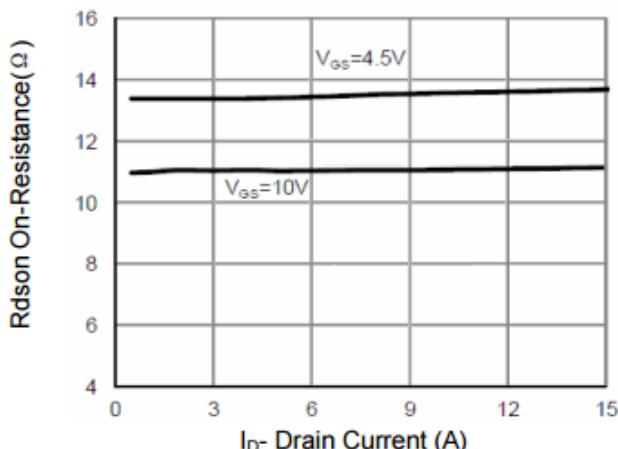


Figure 3 Rdson - Drain Current

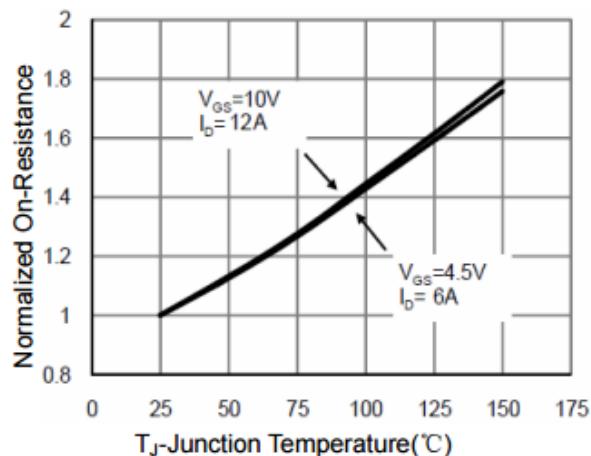


Figure 4 Rdson-JunctionTemperature

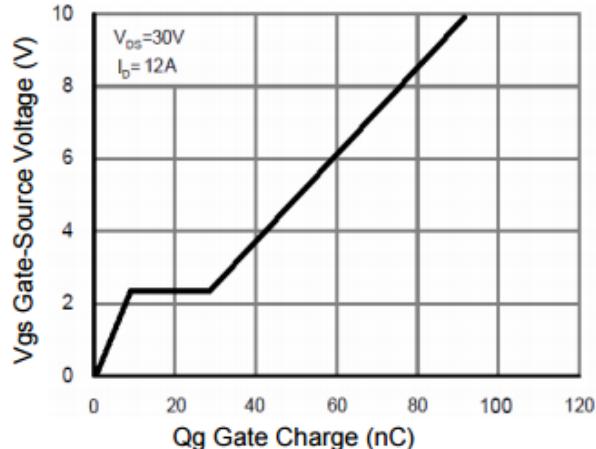


Figure 5 Gate Charge

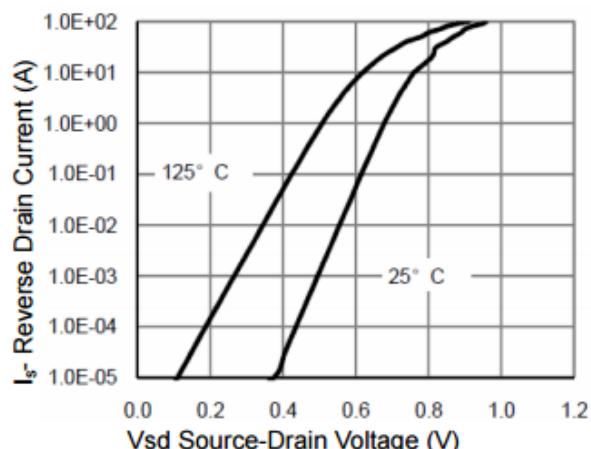


Figure 6 Source- Drain Diode Forward

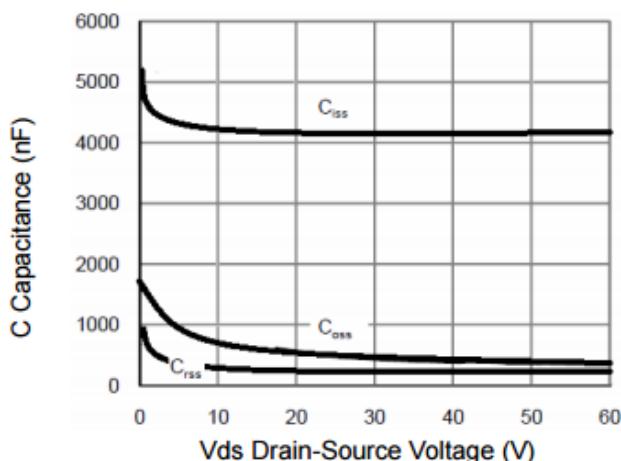


Figure 7 Capacitance vs Vds

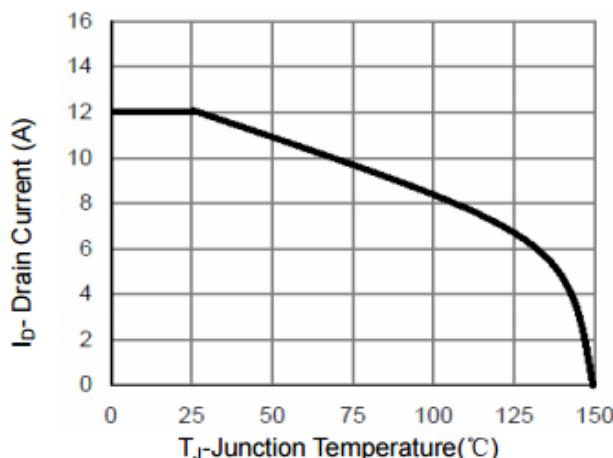


Figure 9 Current De-rating

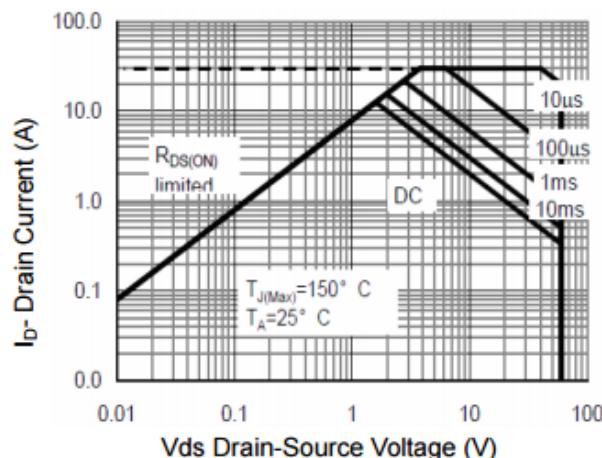


Figure 8 Safe Operation Area

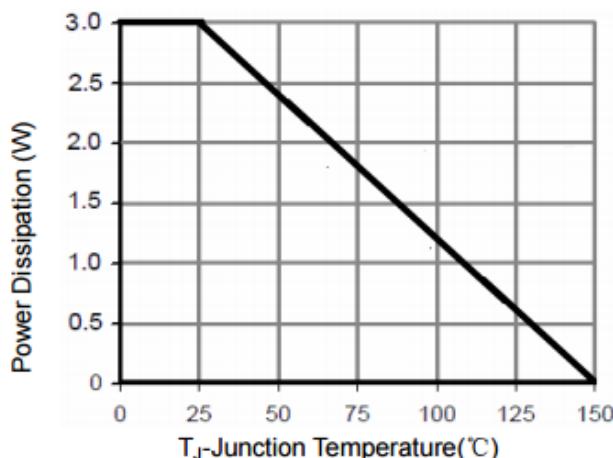
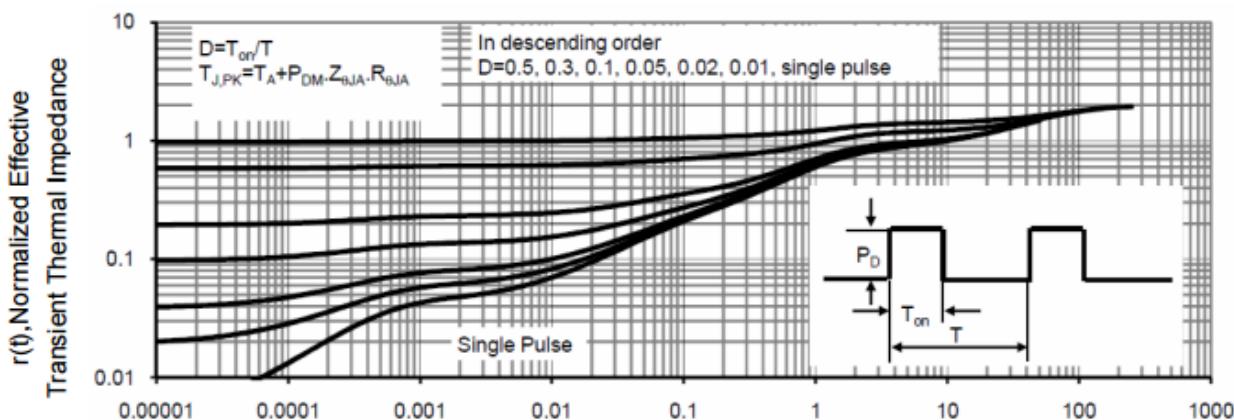


Figure 10 Power De-rating



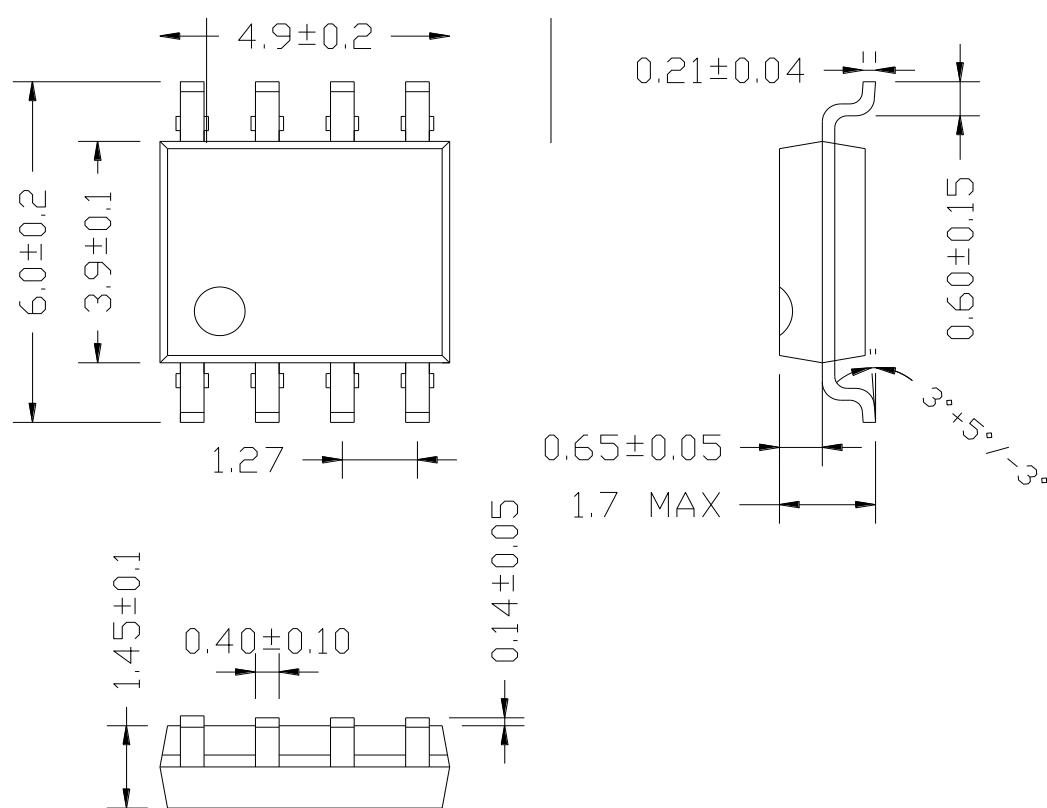
Square Wave Pulse Duration(sec)  
Figure 11 Normalized Maximum Transient Thermal Impedance



### Package Outline

SOP-8

unit: mm



### Recommended soldering pad

